

<b>Notice of References Cited</b>	Application/Control No. 10/041,699	Applicant(s) Patent Under Reexamination HECKMAN	
	Examiner Sang H Nguyen	Art Unit 2877	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,556,211	04-2003	Davis, Steve	345/582
	B	US-6,542,249	04-2003	Kofman et al.	356/601
	C	US-5,953,130	09-1999	Benedict et al.	356/429
	D	US-4,970,666	11-1990	Welsh et al.	345/423
	E	US-4,951,151	08-1990	Sorenson et al.	348/744
	F	US-3,749,493	07-1973	Macovski, Albert	356/2
	G	US-3,742,620	07-1973	Knoll, Ernst	434/152
	H	US-4,070,683	01-1978	Allschuler et al.	356/2
	I	US-H503	08-1988	Keller	356/152
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 09 325 691	12-1997	Japan	Fujisaki et al.	
	O	JP 10 153 960	06-1998	Hapan	Shirakawa et al.	
	P	JP 04 121 778	04-1992	Japan	Murakami et al.	
	Q	JP 08 220 979	08-1996	Japan	Daimon et al.	
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.